P RADWG 4TH

12TH APRIL 2011

G. Spiezia (EN/STI/ECE)

Single Events in the last weeks

- QPS firmware update: is it completed? Will you do it also in the arc?
 - Point 7 (left and right) is updated
 - Point 8: cells 8r, 9R, 10R have been updated
 - Priority for next updates according to the monitoring data (Marco):
 - Point 3 (left and right);
 - Point 8 (left);
 - Point 2 (right);
 - Point 5;
 - Point I;

Follow up from last meeting

- Course on Radiation effects on Electronics
- 11-12 May first course
- RADECS conference on September, 19-23
- www.radecs2011.org
- Storage area for electronics
- Humidity and condensation risk measurement is on going at bld. 954
- RadMon (Battery version) will be installed waiting for P. Muffat
- The requests and the requirement from the users have been collected and summarized in a document to be sent to GS/IS (Patrick Muffat, Isabelle Mardirossian), DGS/RP (Stefan Roesler, Heinz Vincke), RSOs of BE, TE, and EN. They will finalize the task.
- Link to the document

Follow up from last meeting

- Repair of electronic cards coming out from CNGS
- Document is under engineering revision
- List of the labs for non destructive tests: (2009-2010): 36-3-17 (Cryogenics, WorldFip, BLM, Survey), 866-1D-01 (BLM/BPM), 287 TE/EPC lab (Power converters), 30-5-40 (PIC, QPS)
- Lab for destructive test: 530
- EDMS documents: 1056444 (2009), 1071429 (2010), 113936 (2011).

CNRAD

- CNRAD access 31 March: see presentation
- First slot
 - BLM: any news?
 - 3 reference IC,
 - 3 new detectors.
 - Power converter:
 - 1 AC-DC converter for the 600 A; → replacement of a the converter
 - IGBT installation
 - LED:
 - 1 systems with a AC-DC converter. → replacement of the current converter
 - 1 system with transformer and rectifier
 - DerivFIP:
 - version 2.02 with replacement of the weak components found in PSI
 - RadMon:
 - Inversion of the memory voltage for the evaluation of the ratio HEH hadrons/ thermal neutrons;

PSI

- March test:
 - Amplifiers (OPA2227, TL072, INA141), Voltage reference (LM4041, TL431, TL432): No SEL observed. No SET observed (> 100 mV and >10 ns). Small drift on the output.
 - See presentation (P. Peronnard)
- April 15-17
 - 4 transistors (BCP56, BSR17A, BSR18A, BCP53) from TE-EPC;
 - NanoFIP (1 or 2 boards);
 - FipDiag (3 boards);

CNRAD 2009-2010

- Missing reports
 - PIC: only slides
 - WIC
 - Cryogenics (2010)
 - Cooling & Ventilation: only slides
 - EN/EL (2010)
 - Fire detection
 - IT (switch)
 - QPS (2009, 2010): only slides
 - PSI test?
 - TCC2 test ?
 - Power converter: to be completed?
 - FIP repeater: only slides